

Notice of References Cited

Application/Control No.

10/821,387

Applicant(s)/Patent Under
Reexamination
HAN ET AL.

Examiner

YUK CHOW

Art Unit

2629

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0047923 A1	04-2002	Okuno et al.	348/540
*	B	US-7,046,256 B2	05-2006	Credelle, Thomas Lloyd	345/613
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	M	US-			

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NON-PATENT DOCUMENTS

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